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|-----------------------------------|---------------------------------------|------------------------------------------------------------|-------------|
| <b>Notice of References Cited</b> | Application/Control No.<br>10/519,480 | Applicant(s)/Patent Under<br>Reexamination<br>RYU, JUNGHEE |             |
|                                   | Examiner<br>Leynna T. Truvan          | Art Unit<br>2435                                           | Page 1 of 1 |

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|   | B | US-                                              |                 |            |                |
|   | C | US-                                              |                 |            |                |
|   | D | US-                                              |                 |            |                |
|   | E | US-                                              |                 |            |                |
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|   | G | US-                                              |                 |            |                |
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|   | O |                                                  |                 |         |      |                |
|   | P |                                                  |                 |         |      |                |
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|   | X |                                                                                           |

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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